

Search Notes

Application/Control No.

10/729,338

Examiner

JOHN J. LEE

Applicant(s)/Patent under
Reexamination

BAKER ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	11.1,13.4 522,69 127.2,10 126,9	12/1/2008	J.L
455	232.1,15	12/1/2008	J.L
455	67.11,20	12/1/2008	J.L
455	21,24	12/1/2008	J.L
455	67.13, 7	12/1/2008	J.L
370	332,318	12/1/2008	J.L

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
455	11.1,13.4	12/5/2008	J.L
455	127.2,69	12/5/2008	J.L
455	232.1,15	12/5/2008	J.L
Interference and Inventor search		12/5/2008	J.L

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	12/1/2008	J.L